Power MOSFET

30 V, 117 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC–DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_{.1} = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltag	Gate-to-Source Voltage				V
Continuous Drain		T _A = 25°C	I _D	19	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		15	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.5	W
Continuous Drain		T _A = 25°C	I _D	14.5	Α
Current (R _{θJA}) (Note 2)	Steady	T _A = 85°C		11	
Power Dissipation (R _{θJA}) (Note 2)	State	T _A = 25°C	P _D	1.43	W
Continuous Drain		T _C = 25°C	I _D	117	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		91	
Power Dissipation (R _{θJC}) (Note 1)		T _C = 25°C	P _D	93.75	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	230	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and	T _J , T _{stg}	-55 to 175	°C		
Source Current (Body D	I _S	78	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 30 A, R_G = 25 Ω)			E _{AS}	450	mJ
Lead Temperature for So (1/8" from case for 10 s)	ldering Pu	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			°C

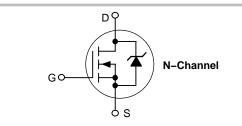
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	4.0 mΩ @ 10 V	117 A
30 V	5.5 mΩ @ 4.5 V	117.6







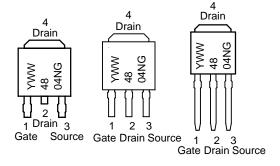


CASE 369C **DPAK** (Bent Lead) STYLE 2

CASE 369AD 3 IPAK (Straight Lead) (Straight Lead

CASE 369D IPAK DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



= Year WW = Work Week 4804N = Device Code = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.6	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	60	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	105	

- Surface–mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface–mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS		1					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				26		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 24 V	T _J = 125°C			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to 11.5 V	I _D = 30 A		3.4	4.0	mΩ
			I _D = 15 A		3.4		1
		V _{GS} = 4.5 V	I _D = 30 A		4.7	5.5	1
			I _D = 15 A		4.6		1
Forward Transconductance	gFS	V _{DS} = 15 V, I _D	= 15 A		23		S
CHARGES AND CAPACITANCES							-
Input Capacitance	C _{iss}				4490		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 7$ $V_{DS} = 12$			952		1
Reverse Transfer Capacitance	C _{rss}	, VDS = 12 V			556		1
Total Gate Charge	Q _{G(TOT)}				30	40	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{D}$	os = 15 V,		5.5		1
Gate-to-Source Charge	Q_{GS}	I _D = 30			13		1
Gate-to-Drain Charge	Q_{GD}				13		1
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 11.5 \text{ V}, V_{I}$ $I_{D} = 30 \text{ s}$			73		nC
SWITCHING CHARACTERISTICS (Note	= 4)					•	•
Turn-On Delay Time	t _{d(on)}				18		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			20		1
Turn-Off Delay Time	t _{d(off)}				24		1
Fall Time	t _f				8		1
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	V _{GS} = 11.5 V, V _I	os = 15 V,		19		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			35		1

Fall Time

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

5

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

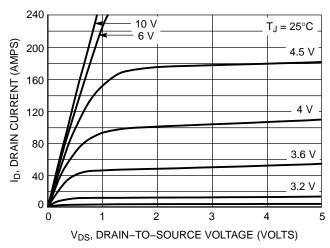
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTE	RISTICS	•				•	•
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$,	$T_J = 25^{\circ}C$		0.81	1.2	V
		I _S = 30 A	T _J = 125°C		0.72		
Reverse Recovery Time	t _{RR}		V _{GS} = 0 V, dls/dt = 100 A/μs,		34		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls}$			19		1
Discharge Time	tb	I _S = 30 A			15		1
Reverse Recovery Time	Q_{RR}				30		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nΗ
Drain Inductance, DPAK	L _D	1			0.0164		1
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		1
Gate Inductance	L _G				3.46		1
Gate Resistance	R _G	1			0.6		Ω

TYPICAL PERFORMANCE CURVES

240

200

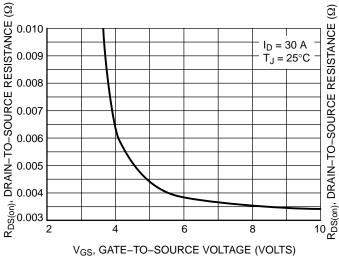
 $V_{DS} \ge 10 \text{ V}$



DRAIN CURRENT (AMPS) 160 120 80 $T_J = 125^{\circ}C$ $T_J = 25^{\circ}C$ Õ 40 $T_J = -55^{\circ}C$ 0 2 4 5 6 7 0

Figure 1. On-Region Characteristics

V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS) Figure 2. Transfer Characteristics



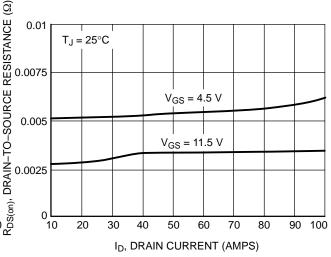
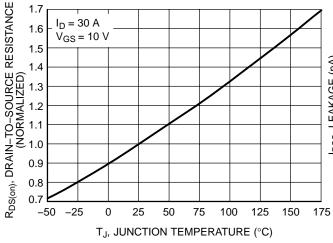


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**



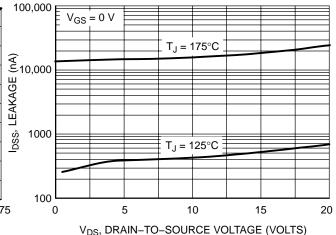
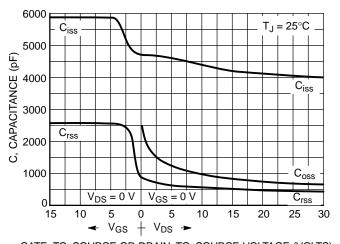


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

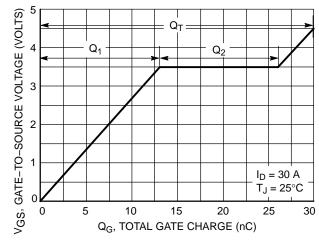


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



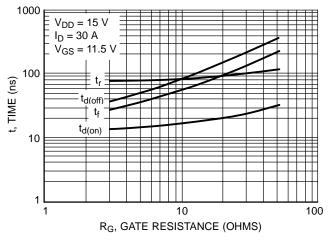


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

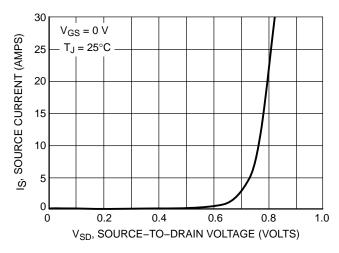


Figure 10. Diode Forward Voltage vs. Current

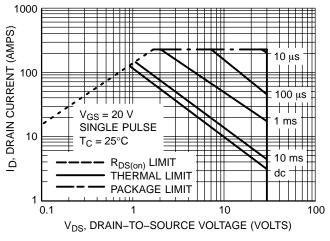


Figure 11. Maximum Rated Forward Biased Safe Operating Area

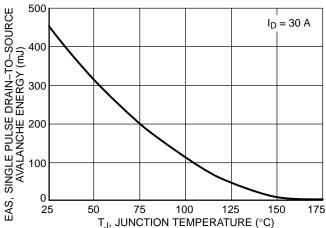


Figure 12. Maximum Avalanche Energy vs.
Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

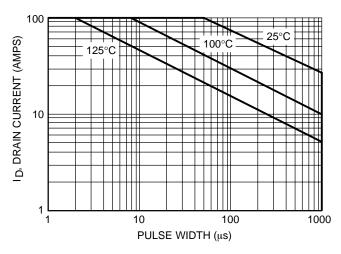


Figure 13. Avalanche Characteristics

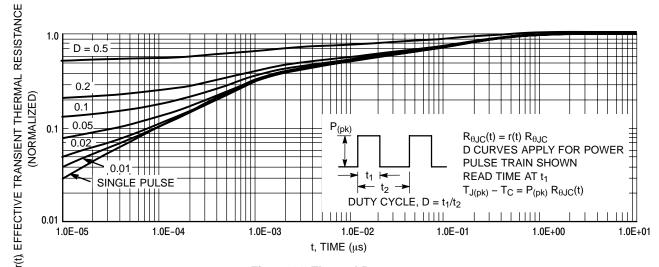


Figure 14. Thermal Response

ORDERING INFORMATION

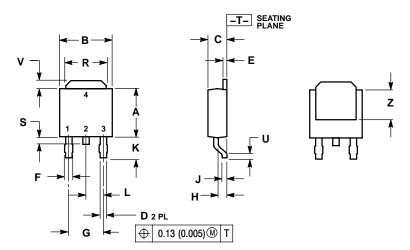
Order Number	Package	Shipping [†]
NTD4804NT4G	DPAK (Pb-Free)	2500/Tape & Reel
NTD4804N-1G	IPAK (Pb-Free)	75 Units/Rail
NTD4804N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units/Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK

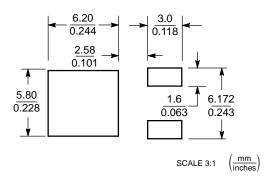
CASE 369C-01 ISSUE O



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
ЫМ	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
c	0.086	0.203	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

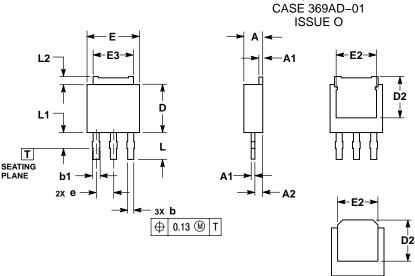
SOLDERING FOOTPRINT*



^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3.5 MM IPAK, STRAIGHT LEAD



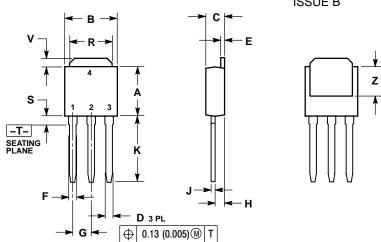
- NOTES:
 1.. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2.. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH

	MILLIMETERS				
DIM	MIN	MAX			
Α	2.19	2.38			
A1	0.46	0.60			
A2	0.87	1.10			
b	0.69	0.89			
b1	0.77	1.10			
D	5.97	6.22			
D2	4.80	-			
E	6.35	6.73			
E2	4.70				
E3	4.45	5.46			
е	2.28	BSC			
L	3.40	3.60			
L1		2.10			
L2	0.89	1.27			

IPAK (STRAIGHT LEAD DPAK)

OPTIONAL CONSTRUCTION

CASE 369D-01 ISSUE B



NOTES

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
U	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29	BSC
Η	0.034	0.040	0.87	1.01
7	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE

- 2. DRAIN 3 SOURCE
- DRAIN

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